

**Search Notes**

Application/Control No.

10/517,269

Examiner

BIN SHEN

Applicant(s)/Patent under  
Reexamination

JANG ET AL.

Art Unit

1657

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
WEST		9/19/2008	BS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search.	9/19/2008	BS